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5868455 MATRA DESIGN SEMICOND



94D 00622 7-49-19-08

80C51/80C31 **CMOS SINGLE - CHIP 8 BIT** MICROCONTROLLER

PRELIMINARY

OCTOBER 1987

- 80C51 CMOS SINGLE-CHIP 8 BIT MICROCONTROLLER with factory mask-programmable ROM.
- 80C31 ROM LESS VERSION OF THE 80C51

80C51/31 : 0 TO 12 MHz.

80C51/31-1:0 TO 16 MHz.

OTHER DEVICES WITH A SPECIFIC **DATA SHEET**

80C51/31-L: Vcc = 2.7V TO 6V (0 TO 6 MHz)

: THE INTERNAL ROM CODE CANNOT BE READ

OR DUMPED AFTER ACTIVATION OF A SPECIAL **PROTECTION**

Features

- POWER CONTROL MODES
- 128 x 8 BIT RAM
- 32 PROGRAMMABLE I/O LINES
- TWO 16-BIT TIMER/COUNTERS
 64K PROGRAM MEMORY SPACE
- FULLY STATIC DESIGN

- HIGH PERFORMANCE SAJI VI CMOS PROCESS
- BOOLEAN PROCESSOR
- 5 INTERRUPT SOURCES
- PROGRAMMABLE SERIAL PORT
- 64K DATA MEMORY SPACE
- TEMPERATURE RANGE :
- Commercial, Industrial and Military

Description

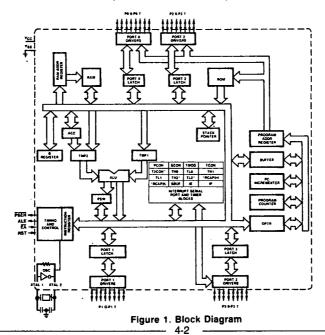
MHS's 80C51 and 80C31 are high performance CMOS versions of the 8051/8031 NMOS single chip 8 bit μ C and is manufactured using a self-aligned silicon gate CMOS process (SAJI VI).

The fully static design of the MHS 80C51/80C31 allows to reduce system power consumption by bringing the clock frequency down to any value, even DC, without loss of data.

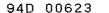
The 80C51 retains all the features of the 8051: 4K bytes of ROM; 128 bytes of RAM; 32 I/O lines; two 16 bit timers a 5-source, 2-level interrupt structure; a full duplex serial port; and on-chip oscillator and clock circuits.

In addition, the 80C51 has two software-selectable modes of reduced activity for further reduction in power consumption. In the Idle Mode the CPU is frozen while the RAM, the timers, the serial port, and the interrupt system continue to function. In the Power Down Mode the RAM is saved and all other functions are inoperative.

The 80C31 is identical to the 80C51 except that it has no on-chip ROM.







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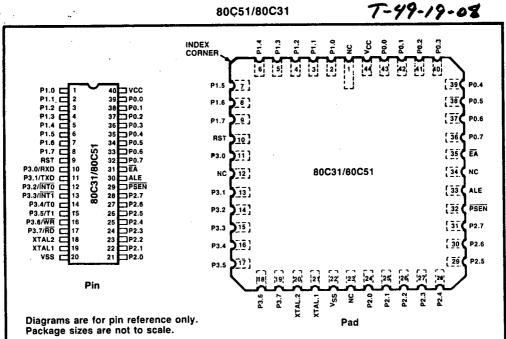




Figure 2. Configurations

IDLE AND POWER DOWN OPERATION

Figure 3 shows the internal Idle and Power Down clock configuration. As illustrated, Power Down operation stops the oscillator. Idle mode operation allows the interrupt, serial port, and timer blocks to continue to function while the clock to the CPU is gated off.

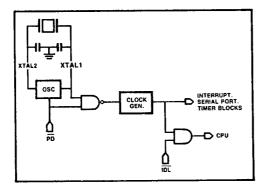


Figure 3. Idle and Power Down Hardware

These special modes are activated by software via the Special Function Register, PCON. Its hardware address is 87H. PCON is not bit addressable.

PCON: Power Control Register

(MSB)							(LSB)	1
SMOD	_	_	_	GF1	GF0	PD	IDL	

Symbol	Position	Name and Function
SMOD	PCON.7	Double Baud rate bit. When set to a 1, the baud rate is doubled when the serial port is being used in either modes 1, 2 or 3.
_	PCON.6	(Reserved)
_	PCON.5	(Reserved)
_	PCON.4	(Reserved)
GF1	PCON.3	General-purpose flag bit.
GF0	PCON.2	General-purpose flag bit.
PD	PCON.1	Power Down bit Setting this bit activates power down operation.
IDL	PCON.0	Ide mode bit. Setting this bit activates idle mode operation.

If 1's are written to PD and IDL at the same time. PD takes, precedence. The reset value of PCON is (0XXX0000).



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Table 1. Status of the external pins during Idle and Power Down modes

Mode	Program Memory	ALE	PSEN	PORT0	PORT1	PORT2	PORT3
idle	Internal	1	1	Port Data	Port Data	Port Data	Port Data
idle	External	1	1	Floating	Port Data	Address	Port Data
Power Down	Internal	0	0	Port Data	Port Data	Port Data	Port Data
Power Down	External	0	0	Floating	Port Data	Port Data	Port Data

Idle Mode

The instruction that sets PCON.0 is the last instruction executed before the Idle mode is activated. Once in the Idle mode the CPU status is preserved in its entirety: the Stack Pointer, Program Counter, Program Status Word, Accumulator, RAM, and all other registers maintain their data during Idle. Table 1 describes the status of the external pins during Idle mode.

There are two ways to terminate the Idle mode. Activa-tion of any enabled interrupt will cause PCON.0 to be cleared by hardware, terminating Idle mode. The inter-rupt is serviced, and following RETI, the next instruction to be executed will be the one following the instruction that wrote a 1 to PCON.0.

The flag bits GF0 and GF1 may be used to determine whether the interrupt was received during normal execution or during the Idle mode. For example, the instruction that writes to PCON.0 can also set or clear one or both flag bits. When Idle mode is terminated by an enabled interrupt, the service routine can examine the status of the flag bits.

The second way of terminating the Idle mode is with a hardware reset. Since the oscillator is still running, the hardware reset needs to be active for only 2 machine cycles (24 oscillator periods) to complete the reset operation

Power Down Mode

The instruction that sets PCON.1 is the last executed prior to entering power down. Once in power down, the oscillator is stopped. The contents of the onchip RAM and the Special Function Register is saved during power down mode. A hardware reset is the only way of exiting the power down mode. The hardware reset initiate the Special Function Register (see Table 1).

In the Power Down mode, VCC may be lowered to minimize circuit power consumption. Care must be taken to ensure the voltage is not reduced until the power down mode is entered, and that the voltage is restored before the hardware reset is applied which frees the oscillator. Reset should not be released until the oscillator has restarted and stabilized.

Table 1 describes the status of the external pins while in the power down mode. It should be noted that if the power down mode is activated while in external program memory, the port data that is held in the Special Function Register P2 is restored to Port 2. If the data is a 1, the port pin is held high during the power down mode by the strong pullup, p1, shown in Figure 4.

Due to static design, the MHS 80C31/C51 clock speed can be reduced until 0 MHz without any data loss in memory or registers. This mode allows step by step utilization, and permits to reduce system power consumption by bringing the clock frequency down to any value. At 0 MHz, the power consumption is the same as in the Power Down Mode.

80C51 I/O PORTS

The I/O port drive of the 80C51 is similar to the 8051. The I/O buffers for Ports 1, 2, and 3 are implemented as shown in figure 4.

When the port latch contains a 0, all pFETS in figure 4 are off while the nFET is turned on. When the port latch makes a 0-to-1 transition, the nFET turns off. The strong pullup pFET, p1, turns on for two oscillator periods, pulling the output high very rapidly. As the output line is drawn high, pFET p3 turns on through the inverter to supply the IOH source current. This inverter and p3 form a latch which holds the 1 and is supported by p2.

When Port 2 is used as an address port, for access to external program of data memory, any address bit that contains a 1 will have is strong pullup turned on for the entire duration of the external memory access.

When an I/O pin on Ports 1, 2, or 3 is used as an input, the user should be aware that the external circuit must sink current during the logical 1-to-0 transition. The maximum sink current is specified as ITL under the D.C. Specifications. When the input goes below approximately 2V, p3 turns off to save ICC current. Note, when returning to a logical 1, p2 is the only internal pullup that is on. This will result in a slow rise time if the user's circuit does not force the input line high.

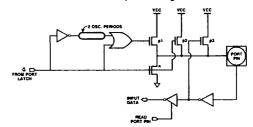


Fig. 4: I/O Buffers in the 80C51 (Ports 1, 2, 3)

80C31/80C51 PIN DESCRIPTIONS

Vss

Circuit ground potential

Supply voltage during normal, Idle, and Power Down operation.

Port 0

Port 0 is an 8-bit open drain bi-directional I/O port. Port O pins that have 1's written to them float, and in that state can be used as high-impedance inputs.

Port 0 is also the multiplexed low-order address and data bus during accesses to external Program and Data





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Memory. In this application it uses strong internal pullups when emitting 1's. Port 0 also outputs the code bytes during program verification in the 80C51. External pullups are required during program verification. Port 0 can sink eight LS TTL inputs.

Port 1

Port 1 is an 8-bit bi-directional I/O port with internal pullups. Port 1 pins that have 1's written to them are pulled high by the internal pullups, and in that state can be used as inputs. As inputs, Port 1 pins that are externally being pulled low will source current (IIL, on the data sheet) because of the internal pullups.

Port 1 also receives the low-order address bytes during program verification. In the 80C51, Port 1 can sink/source three LS TTL inputs. It can drive CMOS inputs without external pullups.

Port 2

Port 2 is an 8-bit bi-directional I/O port with internal pullups. Port 2 pins that have 1's written to them are pulled high by the internal pullups, and in that state can be used as inputs. As inputs, Port 2 pins that are externally being pulled low will source current (IIL, on the data sheet) because of the internal pullups. Port 2 emits the high-order address byte during fetches from external Program Memory and during accesses to external Data Memory that use 16-bit addresses (MOVX @ DPTR). In this application, it uses strong internal pullups when emitting 1's. During accesses to external Data Memory that use 8-bit addresses (MOVX @ Ri), Port 2 emits the contents of the P2 Special Function Register.

It also receives the high-order address bits and control signals during program verification in the 80C51. Port 2 can sink/source three LS TTL inputs. It can drive CMOS inputs without external pullups.

Port 3

Port 3 is an 8-bit bi-directional I/O port with internal pullups. Port 3 pins that have 1's written to them are pulled high by the internal pullups, and in that state can be used as inputs. As inputs, Port 3 pins that are externally being pulled low will source current (IIL, on the data sheet) because of the pullups. It also serves the functions of various special features of the MCS-51 Family, as listed below.

Port Pin	Alternate Function
P3.0	RXD (serial input port)
P3.1	TXD (serial output port)
P3.2	INTO (external interrupt 0)
P3.3	INT1 (external interrupt 1)
P3.4	TO (Timer 0 external input)
P3.5	T1 (Timer 1 external input)
P3.6	WR (external Data Memory write strobe
P3.7	RD (external Data Memory read strobe

Port 3 can sink/source three LS TTL inputs. It can drive CMOS inputs without external pullups.

Det

A high level on this for two machine cycles while the oscillator is running resets the device. An internal pull-down resistor permits Power-On reset using only a capacitor connected to VCC.

ALE

Address Latch Enable output for latching the low byte of the address during accesses to external memory. ALE

is activated as though for this purpose at a constant rate of 1/6 the oscillator frequency except during an external data memory access at which time one ALE pulse is skipped. ALE can sink/source 8 LS TTL inputs. It can drive CMOS inputs without an external pullup.

PSEN

Program Store Enable output is the read strobe to external Program Memory. PSEN is activated twice each machine cycle during fetches from external Program Memory. (However, when executing out of external Program Memory, two activations of PSEN are skipped during each access to external Data Memory). PSEN is not activated during fetches from internal Program Memory. PSEN can sink/source 8 LS TTL inputs. It can drive CMOS inputs without an external pullup.

ĒĀ

When EA is held high, the CPU executes out of internal Program Memory (unless the Program Counter exceeds OFFFH). When EA is held low, the CPU executes only out of external Program Memory. EA must not be floated.

XTAL

Input to the inverting amplifier that forms the oscillator. Receives the external oscillator signal when an external oscillator is used.

XTAL2

Output of the inverting amplifier that forms the oscillator, and input to the internal clock generator. This pin should be floated when an external oscillator is used.

OSCILLATOR CHARACTERISTICS

XTAL1 and XTAL2 are the input and output respectively, of an inverting amplifier which is configured for use as an on-chip oscillator, as shown in figure 5. Either a quartz crystal or ceramic resonator may be used.

To drive the device from an external clock source, XTAL1 should be driven while XTAL2 is left unconnected as shown in figure 6. There are no requirements on the duty cycle of the external clock signal, since the input to the internal clocking circuitry is through a divide-bytwo flip-flop, but minimum and maximum high and low times specified on the Data Sheet must be observed.

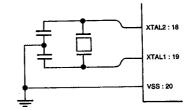


Figure 5. Crystal Oscillator

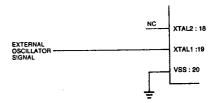


Figure 6. External Drive Configuration



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ABSOLUTE MAXIMUM RATINGS*

Ambient Temperature Under Bias : commercial $\,$ 0°C to 70°C industrial— 40°C to + 85°C $\,$ Storage Temperature -- 65°C to + 150°C Voltage on VCC to VSS - 0.5V to + 7V Voltage on Any Pin to VSS.. — 0.5V to VCC + 0.5V

Power Dissipation 200mW

*NOTICE: Stresses at or above those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress rating only and functional operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied. Exposure to absolute maximum rating conditions may affect device

DC CHARACTERISTICS (see Note 2)

 $(T_A = 0$ °C to 70°C; VCC = 5V· \pm 20 %; VSS = 0V)

Symbol	Parameter	Min	Max	Unit	Test Conditions
VIL	Input Low Voltage	- 0.5	0.2 VCC - 0.1	٧	
VIH	Input High Voltage (Except XTAL and RST)	0,2 VCC + 0.9	VCC + 0.5	٧	
VIH1	input High Voltage (RST and XTAL1)	0.7 VCC	VCC + 0.5	V	
VOL	Output Low Voltage (Ports 1, 2, 3)		0.45	V	IOL = 1.6 mA (note 1)
VOL1	Output Low Voltage Port 0, ALE, PSEN		0.45	٧	IOL = 3.2 mA (note 1)
VOH	Output High Voltage Ports 1, 2, 3	0.9 VCC		٧	IOH = - 10μA
		0.75 VCC		٧	IOH = - 25 μA
		2.4		٧	IOH = - 60 μA VCC = 5V ± 10 %
VOH1	Output High Voltage (Port 0 (Port 0, ALE, PSEN)	0.9 VCC		V	IOH = - 40 μA
		0.75 VCC		٧	IOH = - 150 μA
		2.4		٧	IOH = - 400 µA VCC = 5V ± 10 %
IIL	Logical 0 Input Current Ports 1, 2, 3		- 50	μΑ	Vin = 0.45V
ILI	Input Leakage Current (Port 0, EA)		± 10	μΑ	0.45 < Vin < VCC
ITL	Logical 1 to 0 Transition Current (Ports 1, 2, 3)		650	μΑ	Vin = 2.0V
IPD	Power Supply Current (Power Down Mode)		50	μΑ	VCC = 2.0V (note 2)
RRST	RST Pulldown Resistor	40	125	kΩ	
CIO	Capacitance of I/O Buffer		10	pF	f _C = 1 MHz, T _A = 25°C
ICC	Power supply current Active mode 12 MHz Idle mode 12 MHz		20 5	mA mA	(notes 1,2)





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Note 1:

Note 1:

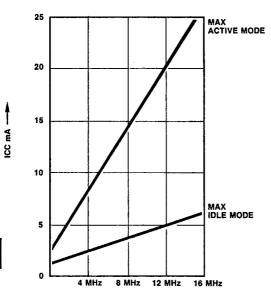
ICC max is given by:

Active Mode: ICCMAX = 1.47 x FREQ + 2.35

Idle Mode: ICCMAX = 0.33 x FREQ + 1.05

where FREQ is the external oscillator frequency in MHz. ICCMAX is given in mA. See Figure 1.

See figures 1 through 5 for ICC test conditions.



FREQ AT XTAL1

Figure 1 : ICC vs. Frequency.
Valid only within frequency specifications
of the device under test.

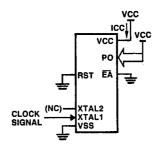


Figure 2 ICC Test Condition, Idle Mode. All other pins are disconnected.

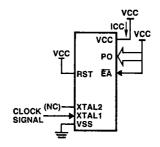


Figure 3 : ICC Test Condition, Active Mode.
All other pins are disconnected.



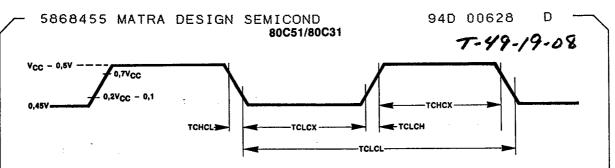


Figure 4: Clock Signal Waveform for ICC Tests in Active and Idle Modes. TCLCH = TCHCL = 5 ns.

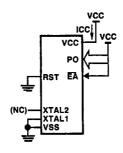


Figure 5: ICC Test Condition, Power Down Mode. All other pins are disconnected.



Note 2:

ICC is measured with all output pins disconnected; XTAL1 driven with TCLCH, TCHCL = 5 ns, VIL = VSS + 5V, VIH = VCC - 5V; XTAL2 N.C.; EA = RST = Port 0 = VCC ICC would be slightly higher if a crystal oscillator used.

Idle ICC is measured with all output pins disconnected; XTAL1 driven with TCLCH, TCHCL = 5 ns, VIL = VSS + 5V, VIH = VCC - 5V; XTAL2 N.C.; Port 0 = VCC; EA = RST = VSS.

Power Down ICC is measured with all output pins disconnected; EA = PORT 0 = VCC; XTAL2 N.C.; RST = VSS.

Note 3: Capacitance loading on Ports 0 and 2 may cause spurious noise pulses to be superimposed on the VOLS of ALE and Ports 1 and 3. The noise is due to external bus capacitance discharging into the Port 0 and Port 2 pins when these pins make 1 to 0 transitions during bus operations. In the worst cases (capacitive loading 100 pF), the noise pulse on the ALE line may exceed 0.45V with maxi VOL peak 0.6V. A Schmitt Trigger use is not necessary.

EXTERNAL CLOCK DRIVE CHARACTERISTICS (XTAL 1)

••		Variat	ole clock to 12 MHz	
Symbol	Parameter	Min	Max	Unit
1/TCLCL	Oscillator Frequency		12 (80C51-1) 16	MHz MHz
TCHCX	High Time	20		ns
TCLCX	Low Time	20		ns
TCLCH	Rise Time		20	ns
TCHCL	Fall Time		20	ns



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A.C. PARAMETERS :

TA = 0° C + 70° C; VSS = 0V; VCC = 5V \pm 20 % (commercial)

TA = -40°C + 85°C; VSS = 0V; VCC = 5V \pm 20 % (industrial)

(Load Capacitance for Port 0, ALE, and PSEN = 100 pf; Load Capacitance for All Other Outputs = 80 pf).

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EXTERNAL PROGRAM MEMORY CHARACTERISTICS

Symbol	Parameter (notes 4 and 5)	Min	Max	Units
TLHLL	ALE Pulse Width	2TCLCL-40		ns
TAVLL	Address Valid to ALE	TCLCL-55		ns
TLLAX	Address Hold After ALE	TCLCL-35		ns
TLLIV	ALE to Valid Instr in		4TCLCL-100	ns
TLLPL	ALE to PSEN	TCLCL-40		ns
TPLPH	PSEN Pulse Width	3TCLCL-45		ns
TPLIV	PSEN to Valid Instr in		3TCLCL-105	ns
TPXIX	Input Instr Hold After PSEN	0		ns
TPXIZ	Input Instr Float After PSEN		TCLCL-25	ns
TPXAV	PSEN to Address Valid	TCLCL-8		ns
TAVIV	Address to Valid Instr in		5TCLCL-105	ns
TPLAZ	PSEN Low to Address Float	4	10	ns



EXTERNAL DATA MEMORY CHARACTERISTICS

Symbol	Parameter (notes 4 and 5)	Min	Max	Units
TRLRH	RD Pulse Width	6TCLCL-100		ns
TWLWH	WR Pulse Width	6TCLCL-100		ns
TLLAX	Data Address Hold After ALE	TCLCL-35		ns
TRLDV	RD to Valid Data in		5TCLCL-165	ns
TRHDX	Data Hold After RD	0		ns
TRHDZ	Data Float After RD		2TCLCL-70	ns
TLLDV	ALE to Valid Data in		8TCLCL-150	ns
TAVDV	Address to Valid Data in		9TCLCL-165	ns
TLLWL	ALE to WR or RD	3TCLCL-50	3TCLCL + 50	ns
TAVWL	Address to WR or RD	4TCLCL-130		ns
TQVWX	Data Valid to WR Transition	TCLCL-60		ns
TQVWH	Data Setup to WR High	7TCLCL-150		ns
TWHQX	Data Hold After WR	TCLCL-50		ns
TRLAZ	RD Low to Address Float		0	ns
TWHLH	RD or WR High to ALE High	TCLCL-40	TCLCL + 40	ns



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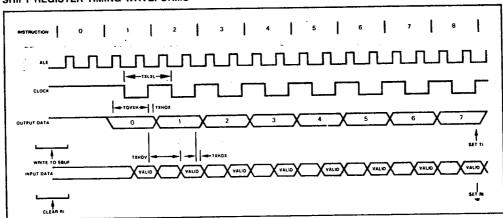
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SERIAL PORT TIMING - SHIFT REGISTER MODE

Symbol	Parameter	Min	Max	Units
TXLXL	Serial Port Clock Cycle Time	12TCLCL		μS
TQVXH	Output Data Setup to Clock Rising Edge	10TCLCL—133		กร
TXHQX	Output Data Hold After Clock Rising Edge	2TCLCL—117		ns
TXHDX	Input Data Hold After Clock Rising Edge	0		ns
TXHDV	Clock Rising Edge to Input Data Valid		10TLCL—133	ns

SHIFT REGISTER TIMING WAVEFORMS



EXPLANATION OF THE AC SYMBOLS

Each timing symbol has 5 characters. The first character is always a 'T' (stands for time). The other characters, depending on their positions, stand for the name of a signal or the logical status of that signal. The following is a list all the characters and what they stand for.

: Address.

: Clock. : Input data. : Logic level HIGH. D Н

: Instruction (program memory contents). : Logic level LOW, or ALE.

: PSEN.

Q : Output data. : READ signal. R

Т : Time.

٧ : Valid.

W: WRITE signal.

: No longer a valid logic level.

Z : Float.

EXAMPLE:

 $\begin{array}{ll} \text{TAVLL} &=& \text{Time for Address Valid to ALE low.} \\ \text{TLLPL} &=& \text{Time for ALE low to } \overline{\text{PSEN}} \text{ low.} \\ \end{array}$



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ABSOLUTE MAXIMUM RATINGS*

Ambiant Temperature Under Bias . . . - 55°C to +125°C Storage Temperature -65°C to +150°C Voltage on Any Pin to VSS. -0.5 V to VCC + 0.5 V Voltage on VCC to VSS $-0.5\ V$ to 6.5 V

Power Dissipation 200 mW

*NOTICE: Stresses above those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress rating only and functional operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

DC CHARACTERISTICS

TA = -55° C to + 125°C; VSS = 0V VCC = 5V \pm 10 %

VIL1	Input Low Voltage (Except EA) Input Low Voltage (EA) Input High Voltage (Except XTAL1, RST) Input High Voltage (XTAL1, RST) Output Low Voltage (Ports 1, 2, 3) Output Low Voltage (Port 0, ALE, PSEN)	0.2VCC+1.1	0.2 VCC - 25 0.2 VCC - 45 VCC + 0.5 VCC + 0.5	v v v v	
VIH III (() VIH1 () VOL (() VOL1 () VOH ()	Input High Voltage (Except XTAL1, RST) Input High Voltage (XTAL1, RST) Output Low Voltage (Ports 1, 2, 3) Output Low Voltage	0.2VCC+1.1	VCC + 0.5	v	
VOL (() VOH () VOH ()	(Except XTAL1, RST) Input High Voltage (XTAL1, RST) Output Low Voltage (Ports 1, 2, 3) Output Low Voltage		VCC + 0.5	V	
VOL (() VOL1 () VOH ()	(XTAL1, RST) Output Low Voltage (Ports 1, 2, 3) Output Low Voltage	0.7 VCC			
VOL1 ((Ports 1, 2, 3) Output Low Voltage		0.45	V	
VOH C			L		IOL = 1.6 mA (note 3)
		*	0.45	V	IOL = 3.2 mA
	Output High Voltage (Ports 1, 2, 3)	2.4		٧	IOH = - 60µA VCC = 5V ± 10%
	# •	0.75 VCC		V-	IOH = - 25 μA
	wa co	0.9 VCC		V	IOH = - 10 μA
- 10	Output High Voltage (Port 0 in External Bus	2.4		٧	IOH = - 400 μA VCC = 5V ± 10%
"	Mode, ALE, PEN)	0.75 VCC		٧	IOH = - 150 μA
		0.9VCC		V	IOH = 40 μA (Note 2)
IIL L	Logical 0 Input Current Ports 1, 2, 3		- 75	μΑ	Vin = 0.45V
	Logical 1 to 0 Transition Current (Ports 1, 2, 3)		- 750	μΑ	Vin = 2 V
ILI I	Input Leakage Current (Port 0, EA)		± 10	μА	0.45 < Vin < VCC
RRST F	Reset Pulldown Resistor	50	150	KOhm	
CIO F	Pin Capacitance		10	ρF	Test Freq = 1 MHz, TA = 25°C
IPD F	Power Down Current		75	μΑ	VCC = 2 to 6 V
	Power supply current Active mode 12 MHz Idle mode 12 MHz		21 7	mA mA	VCC = 5.5V VCC = 5.5V





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A.C. PARAMETERS :

 $TA = 0^{\circ}C + 70^{\circ}C$; VSS = 0V

 $TA = 5V \pm 10\%$

(See Note 2 - Load Capacitance for Port 0, ALE, and PSEN = 100 pf; Load Capacitance for All Other Outputs = 80 pf).

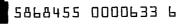
EXTERNAL PROGRAM MEMORY CHARACTERISTICS

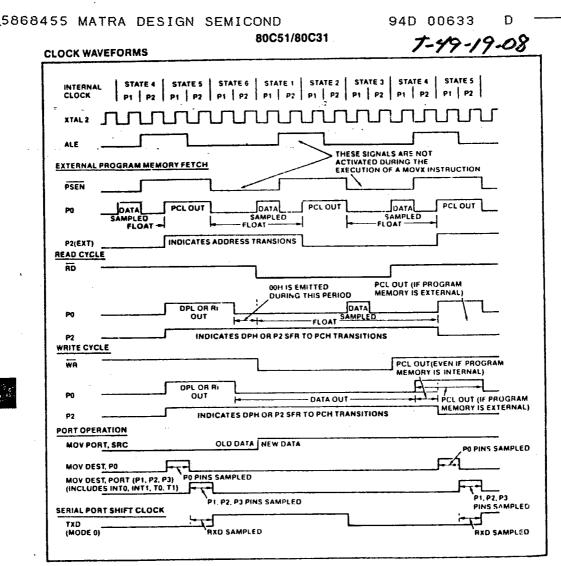
FREQ = 12 MHz (MAX)

Symbol	Parameter	Min	Max	Units
TLHLL	ALE Pulse Width	2TCLCL-55		ns
TAVLL	Address Valid to ALE	TCLCL-70		ns
TLLAX	Address Hold After ALE	TCLCL-50		ns
TLLIV	ALE to Valid Instr in		4TCLCL-115	ns
TLLPL	ALE to PSEN	TCLCL-55		ns
TPLPH	PSEN Pulse Width	3TCLCL-60		ns
TPLIV	PSEN to Valid Instr in		3TCLCL-120	ns
TPXIX	Input Instr Hold After PSEN	0		пѕ
TPXIZ	Input Instr Float After PSEN		TCLCL-40	ns
TPXAV	PSEN to Address Valid	TCLCL-8		ns
TAVIV	Address to Valid Instr in		5TCLCL-120	ns
TPLAZ	PSEN Low to Address Float		25	ns

EXTERNAL DATA MEMORY CHARACTERISTICS 🚙 🤊

Symbol	Parameter	Min	Max	Units
TRLRH	RD Pulse Width	6TCLCL-100		ns
TWLWH	WR Pulse Width	6TCLCL-100		ns
TLLAX	Data Address Hold After ALE	TCLCL-35		ns
TRLDV	RD to Valid Data in		5TCLCL-185	ns
TRHDX	Data Hold After RD	0		ns
TRHDZ	Data Float After RD		2TCLCL-85	ns
TLLDV	ALE to Valid in		8TCLCL-170	ns
TAVDV	Address to Valid Data in		9TCLCL-185	ns
TLLWL	ALE to WR or RD	3TCLCL-65	3TCLCL+65	ns
TAVWL.	Address to WR or RD	4TCLCL-145		ns
TQVWX	Data Valid to WR Transition	TCLCL-75	ns	J
TQVWH	Data Setup to WR High	7TCLCL-150		ns
TWHQX	Data Hold After WR	TCLCL-65		ns
TRLAZ	RD Low to Address Float		0	ns
TWHLH	RD or WR High to ALE High	TCLCL-65	TCLCL+65	ns





This diagram indicates when signals are clocked internally. The time it takes the signals to propagate to the pins, however, ranges from 25 to 125 ns. This propagation delay is dependent on variables such as temperature and pin loading. Propagation also varies from output to output and component to component. Typically though (TA = 25°C, fully loaded) RD and WR propagation delays are approximately 50 ns. The other signals are typically 85 ns. Propagation delays are incorporated in the AC specifications.





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80C51/80C31

Table 1. MCS 3-51 Instruction Set Description

T-49	-/9	-08
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ARITH	ARITHMETIC OPERATIONS				
-					
Mnemo			Byte t	-76	
ADD	A,Rn	Add register to		,	
		Accumulator	1	'	
ADD	A.direct	Add direct byte to	_	. 1	
		Accumulator	2	۱ ۱	
ADD	A.@Rı	Add indirect RAM to		. 1	
1		Accumulator	1	1	
ADD	A,≉data	Add immediate data to	_	1	
i		Accumulator	2	1	
ADDC	A.Rn	Add register to			
ł		Accumulator with Carry	1	1	
ADDC	A,direct	Add direct byte to A			
		with Carry flag	2	¹	
ADDC	A,@Ri	Add indirect RAM to A		1	
		with Carry flag	1	1	
ADDC	A.#data	Add immediate data to		- 1	
		A with Carry flag	2	1	
SUBB	A,Rn	Subtract register from A		- 1	
· ·		with Borrow	1	-1	
SUBB	A, direct	Subtract direct byte		- 1	
10000		from A with Borrow	2	1	
SUBB	A,@Ri	Subtract indirect RAM			
13000	,@	from A with Borrow	1	1	
SUBB	A.#data	Subtract immed data			
3000	A, ruata	from A with Borrow	2	1	
INC	Α ,	Increment Accumulator	-	i	
	Rn		i	1	
INC	• • • • •	Increment register	2	i	
INC	direct	Increment direct byte	_	1	
INC	@Rı	Increment indirect RAM		2	
INC	DPTR	Increment Data Pointer	1		
DEC	A	Decrement Accumulator		1	
DEC	Rn	Decrement register	1	1	
DEC	direct	Decrement direct byte	2	1	
DEC	@Ri	Decrement indirect			
İ		RAM	1	1	
MUL	AB	Multiply A & B	1	4	
DIV	AB	Divide A by B	1	4	
DA	Α	Decimal Adjust			
1		Accumulator	1	1	
LOGIC	CAL OPERATIO	NS			
Mnem	onic	Destination	Byte	Cvc	
ANL	A.Rn	AND register to	-,	-,-	
MINE	A,DII	Accumulator	1	1	
1	A due4	AND direct byte to:	•	•	
ANL	A,direct	AND direct byte to: -	2	1	
1	4.60		2	•	
ANL	A.@Rı	AND indirect RAM to	,	1	
1		Accumulator	1	•	
ANL	A,#data	AND immediate data to			
1		Accumulator	2	1	
ANL	direct.A	AND Accumulator to	_		
I		direct byte	2	1	
ANL	direct.#data	AND immediate data to			
1	•	direct byte	3	2	
ORL	A,Rn	OR register to			
1		Accumulator	1	1	
ORL	A.direct	OR direct byte to			
	•	Accumulator	2	1	
1					

LO	LOGICAL OPERATIONS (CONTINUED)				
	nemor		Destination	Byle	Cyc
OF		A,@Ri	OR indirect RAM to	-	
ľ			Accumulator	1	1
OF	aı .	A.#data	OR immediate data to		ļ
ľľ	••-	,	Accumulator	2	1
OF	RL	direct.A	OR Accumulator to		
۱ ٔ	-		direct byte	2	1
O	RL	direct.#data	OR immediate data to		
١ ً			direct byte	3	2
XF	a L	A,Rn	Exclusive-OR register to		
1			Accumulator	1	1
ΧF	₹L	A,direct	Exclusive-OR direct		
	-		byte to Accumulator	2	1
XF	aL.	A.@Ri	Exclusive-OR indirect		
1		-	RAM to A	1	1
XF	₹L	A, #data	Exclusive-OR	_	_
1			immediate data to A	2	1
XF	RL	direct,A	Exclusive-OR Accumu-	_	
1			lator to direct byte	2	1
X	RL	direct,#data	Exclusive-OR im-	_	_
I			mediate data to direct	3	2
C	LR	A	Clear Accumulator	1	1
C	PL	Α	Complement		_
			Accumulator	. 1	1
RI	L	Α	Rotate Accumulator Lef	1 1	1
R	LC	A	Rotate A Left through		
			the Carry flag	1	1
R	R	A	Rotate Accumulator		_
			Right	1	1
R	RC	Α	Rotate A Right through		
1			Carry flag	1	1
S	WAP	Α	Swap nibbles within the		
1			Accumulator	1	1
1					
P	ATA T	RANSFER			
l _M	Inemo	nic	Description	Byte	• Cyc
	100	A,Rn	Move register to		
1"	٠.	•	Accumulator	. 1	1
IM	100	A, direct	Move direct byte to		
1			Accumulator	2	1
IN	IOV	A.@Rı	Move indirect RAM to		
1		Ç.	Accumulator	1	1
I۸	10V	A.#data	Mov immediate data to		
1"			Accumulator	2	1
ĺ٨	VON	Rn.A	Move Accumulator to		
1	. •		register	1	1
١٨	VON	Rn.direct	Move direct byte to		
1"			register	2	2
1	VON	Rn.#data	Move immediate data to		
1"			register	2	1
I.	VON	direct.A	Move Accumulator to		
1			direct byte	2	1
IN	VON	direct,Rn	Move register to direct		_
			byte	2	2
١N	VON	direct, direct		_	_
			direct	3	2
٨	VON	direct.@Ri	Move indirect RAM to	_	
1			direct byte	2	2





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80C51/80C31 Table 1. (Cont.)

			<u> </u>		
	DATA T	RANSFER (CO	NTINUED)		
1	Mnemo	nic	Description	Byle	Cyc
	MOÝ	direct,#data	Move immediate data to	•	•
ļ			direct byte	3	2
1	MOV	@Ri,A	Move Accumulator to		
			Indirect RAM	1	1
	MOV	@Ri,direct	Move direct byte to		
•			indirect RAM	2	2
-	MOV	@Ri,#data	Move immediate data to	_	
1			Indirect RAM	2	1
1	MOV	DP I H,#Gata 16	Load Data Pointer with a 16-bit constant	3	2
	MOVC	A.@A+DPTR	Move Code byte relative	3	۷
	MOVC	A,@ATUPIN	to DPTR to A	1	2
1	MOVO	A,@A+PC	Move Code byte relative	•	-
		7,047.10	to PC to A	1	2
	MOVX	A,@Ri	Move External RAM (8-		_ :
			bit addr) to A	1	2
	MOVX	A,@DPTR	Move External RAM (16-		
ĺ			bit addr) to A	1	2
	MOVX	@Ri.A	Move A to External RAM		
		_	(8-bit addr)	1	2
	MOVX	@DPTR,A	Move A to External RAM		
		_	(16-bit addr)	1	2
	PUSH	direct	Push direct byte onto		
			stack	2	2
	POP	direct	Pop direct byte from		
			stack	2	2
	XCH	nR,A	Exchange register with	_	_
ļ			Accumulator	1	1
į	XCH	A,direct	Exchange direct byte		1
	V-011	4 OB:	with Accumulator	2	'
	XCH	A,@Ri	Exchange indirect RAM with A	1	1
	VOLID	A 00:	Exchange low-order	'	'
1	XCHD	A.@Ri	Digit ind RAM w A	1	•
İ			Digit ind NAM # A	•	'
	BOOLE	AN VARIABLE	MANIPULATION		
	Mnemo	nic	Description	Byte	Cyc
	CLR	С	Clear Carry flag	1	1
	CLR	bit	Clear direct bit	2	1
	SETB	Ç	Set Carry flag	1	1
	SETB	bit	Set direct Bit	2	1
	CPL	C	Complement Carry flag	1	1
	CPL	bit	Complement direct bit	2	1
	ANL	C,bit	AND direct bit to Carry	•	
1		0.154	flag	2	2
1	ANL	C,1 bit	AND complement of	2	2
	ORL	C/bit	OR direct bit to Carry	2	2
	OKL	C/OR	flag	2	2
- 1			ridg	~	-

OR complement of

Move direct bit to Carry

2 2

2 2

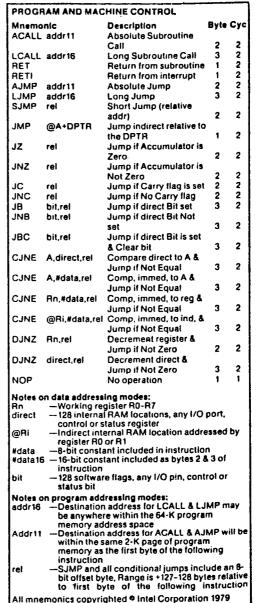
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direct bit to Carry

Move Carry flag to

flag

direct bit





ORL

MOV

MOV

C,1 bit

C/bit

bit.C



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80C51/80C31

Table 2. Instruction Opcodes in Hexadecimal Order

Hex Code	Number of Bytes	Mnemonic	Operands
00	1	NOP-	
01	2	AJMP	code addr
02	3	LJMP	code addr
03	1	RR	A .
04	1	INC	A 1
05	2	INC	data addr
06	1	INC	@R0
07	1	INC	@R1
08	1	INC	RO [
09	1	INC	R1
0A	1	INC	R2
OB	1	INC	R3
0C	1	INC	R4
0D	1	INC	R5
0E	1	INC	R6
OF	1	INC	R7
10	3	JBC	bit addr, code addr
11	2	ACALL	code addr
12	3	LCALL	code addr
13	1	RRC	Ą
14	1	DEC	Α
15	2	DEC	data addr
16	1	DEC	@R0
17	1	DEC	@R1
18	4	DEC	R0
19	1	DEC	R1
1A	1	DEC	A2
18	1	DEC	R3 R4
10	1	DEC	
10	1	DEC	R5 R6
16	1	DEC	R7
1F	1 3	DEC	bit addr, code addr
20	_	JB A MAD	code addr
21	2	AJMP	Code addi
22	1	RET	A
23	1 2	RL ADD	A.#data
24	2	ADD	A,#data eddr
25	1	ADD	A,@R0
26	1	ADD	A,@R1
28	i	ADD	A,RO
28	;	ADD	A.R1
29 2A	†	ADD	A.R2
28	· i	ADD	A,R3
2C	i	ADD	A,R4
20	'n	ADD	A,R5
2E	i	ADD	A.R6
2F	i	ADD	A.R7
30	3	JNB	bit addr. code addr
31	2	ACALL	code addr
32	ī	RETI	
1		• • • • • • • • • • • • • • • • • • • •	

Hex	Number	Mnemonic	Operands
Code	of Byles		
33	1	ALC	A
34	2	ADDC	, A.#data
35	2	ADDC	A.data addr
36	1	ADDC	A.@R0
37	1	ADDC	A.@R1
38	1	ADDC	A.RO
39	1	ADDC	A,R1
3A	1 .	ADDC	A,R2
38	1	ADDC	A.R3
3C	1	ADDC	A,R4
] 3D	1	ADDC	A,R5
3E	1	ADDC	A,R6
3F	1	ADDC	A.R7
40	2	JC	code addr
41	2	AJMP	code addr
42	2	ORL	data addr.A data addr.#data
43	. 3	ORL	
44	. 5	ORL	A.#data
45	2	ORL	A,data addr
46	1	ORL	A.@R0
47	1	ORL	A.@R1
48	1	ORL	A,R0
49	1	ORL	A,R1
4A	1	ORL	A.R2
48	1	ORL	A,R3 A.R4
4C	1	ORL ORL	A,R5
4D	1	ORL	A,R6
4E	1	ORL	A.R7
4F		JNC	code addr
50	2 2	ACALL	code addr
51	2	ANL	data addr,A
52	3	ANL	data addr,#data
53	2	ANL	A.#data
54	_	ANL	A.data addr
55	2 1	ANL	A,@R0
56	1	ANL	A@R1
57 58	i	ANL	A.RO
59	1	ANL	A,R1
1	'n	ANL	A,R2
5A 5B	,	ANL	A.R3
5C	i	ANL	A,R4
5D	1	ANL	A,R5
5E	i	ANL	A,R6
5F	1	ANL	A,R7
5r 60	2	JZ	code addr
61	2	AJMP	code addr
62	2	XRL	data addr A
63	3	XRL	data addr,#data
64	2	XAL	A,#data
65	2	XRL	A,data addr





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80C51/80C31 Table 2, (Cont.)

			
Hex		Mnemonic	Operands
Code	of Bytes		
66	1	XRL	A,@R0
67	i	XRL	A,@R1
68	1	XRL	A.RO
69	i	XRL	A,R1
6A	i	XRL	A,R2
68	i	XRL	A.R3
6C	i	XRL	A.R4
6D	1	XRL	A,RŞ
6E	1	XAL	A,R6
6F	i	XRL	A,R7
70	2	JNZ	code addr
71	2	ACALL	code addr
72	2	ORL	C.bit addr
73	1	JMP	@A+DPTR
74	2	MOV	A.#dala
75	3	MOV	data addr,#data
76	. 2	MOV	@R0,#data
77	2	MOV	@R1,#data
78	2	MOV	R0.#data
79	2	MOV	R1,#data
7A	2	MOV	R2.#data
7B	2	MOV	R3.#data
7C	2	MOV	R4,#data
70	2	MOV	R5.#data
7E	2	MOV	R6.#data
7F	2	MOV	R7.#data
80	2	SJMP	code addr
81	2	AJMP	code addr
82	2	ANL	C.bit addr
83	1	MOVC	A.@A+PC
84	1	DIV	AB
85	3	MOV	data addr, data addr
86	2	MOV	data addr.(@R0
1	2	MOV	data addr.@R1
87 88	2	MOV	data addr,@N1
88	2	MOV	data addr.R1
	2	MOV	data addr.R2
8A 8B	2	MOV	data addr.R3
86 8C	2 .	MOV	data addr.R4
	2	MOV	data addr R5
8D	2	MOV	data addr.R6
8E 8F	2	MOV	data addr, R7
	3	MOV	DPTR.#data
90	2	ACALL	code addr
91	2		
92	_	MOV	bit addr,C A,@A+DPTR
93	1 2	MOVC	_
94	-	\$UBB	A,#data A,data addr
95	2	SUBB	
96	1	SUBB SUBB	A.@R0 A.@R1
97	91 T		A,R0
98	1	SUBB -	n,nv

<u> </u>			
Hex	Number	Mnemonic	Operands
Code	of Bytes	·	·
99	1	SUBB	A,R1
9A	1	SUBB	A,R2
9B	1 -	SUBB	A,R3
9C	1	SUBB	A,R4
9 D	1	SUBB	A,R5
9E	1	SUBB	A.R6
9F	1	SUBB	A.R7
A0	2	ORL	C,/bit addr
Al	2	AJMP	code addr
A2	2	MOV	C,bit addr
A3	1	INC	DPTR
A4	1	MUL	AB
A5		reserved	
A6	2	MOV	@R0.data adr
A7	2	MOV	@R1,data addi
A8	2	MOV	RO,data addr
A9	2	MOV	R1,data addr
AA	2	MOV	R2.data addr
AB	2	MOV	R3.data addr
AC	2	MOV	R4.data addr
AD	2	MOV	R5.data addr
AE	2	MOV	R6.data addr
AF	2	MOV	R7,data addr
В0	2	ANL	C./bit addr
BI	2	ACALL	code addr
B2	2	CPL	bit addr
B3	1	CPL	C
B4	3	CJNE	A.#data.code addr
85	3	CJNE	A,data addr,code addr
B6	3	CJNE	@R0.#data.code addr
B7	3	CJNE	@R1,#data,code addr
B8	3	CJNE -	R0.#data.code addr
89	3.	CJNE	R1.#data,code addr
BA	3	CJNE	R2,#data.code addr
88	3	CJNE	R3.#data,code addr
BC		CJNE	R4 #data.code addr
BD	3	CJNE	R5.#data.code addr
BE	3	CJNE	R6,#data.code addr
BF	3	CINE	R7,#data.code addr
CO	2	PUSH	data addr
Ci	2	AJMP	code addr
C2	2	CLR	bit addr
C3	1	CLR	C
C4	ì	SWAP	Ä
C5	2	XCH	A,data addr
C6	1	XCH	A,@R0
C7	1	XCH	A.@R1
C8	1	XCH	A.RO
C9	1	XCH	A,R1
CA	1	XCH	A.R2
СВ	.1	XCH	A,R3
"	. •		





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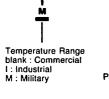
80C51/80C31 Table 2. (Cont.)

Hex Code		Mnemonic	Operands
CC	1	XCH	A.R4
CD	1	XCH	A,R5
CE	1.	XCH	A,R6 ;
CF	1	XCH	A,R7
DO	2	POP	data addr
D1	2	ACALL	code addr
D2	2	SETB	bit addr
D3	1	SETB	C ,
D4	1	DA	A
D5	3	DJNZ	data addr.code addr
D6	1	XCHD	A.@R0
D7	1	XCHD	A,@R1
D8	2	DJNZ	R0.code addr
D9	2	DJNZ	R1.code addr
DA	2	DJNZ	R2.code addr
DB	2	DJNZ	R3.code addr
DC	2	DJNZ	R4.code addr
00	2	DJNZ	R5.code addr
DE	2	DJNZ	R6.code addr
DF	2	DJNZ	R7.code addr
EO	1	MOVX	A,@DPTR
Ε1	2	AJMP	code addr
E2	1	MOVX	A,@R0
E3	1	MOVX	A.@R1
E4	1	CLR	Α .
E5	2	MOV -	A,data addr

Hex Code	Number of Bytes	Mnemonic	Operands
E6	1	MOV	A,@R0
E7	1	MOV	A,@R1
E8 -	1	MOV	A,R0
E9	1	MOV	A.R1
EΑ	1	MOV	A,R2
EΒ	1	MOV	A,R3
EC	1	MOV	A,R4
ED	1	MOV	A.R5
EE	1	MOV	A,R6
EF	1	MOV	A.R7
FO	1	MOVX	@DPTR,A
Fi	2	ACALL	code addr
F2	1	MOVX	@R0,A
F3	1	MOVX	@R1,A
F4	1	CPL	Α
F5	2	MOV	data addr.A
F6	1	MOV	@R0.A
F7	1	MOV	@R1.A
F8	1	MOV	RO,A
F9	1	MOV	R1,A
FA	1	MOV	R2,A
FB	1	MOV	R3.A
FC	1	MOV	R4 A
FD	1	MOV	R5.A
FE	1	MOV	R6.A
FF	1	MOV	R7.A







Package Type
P: Plastic
S: PLCC
D: Cerdip
R: LCC
J: J leaded LCC

80C31 80C51 Part Number 80C51 Rom 4K × 8 80C31 External Rom

Customer Rom Code (80C51 only)

- 1:16 MHz Version /B: Military Program

